

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/867,259	BAE ET AL.	
Examiner	Art Unit	
 Tri V. Nguyen	3622	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED			
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SEARCH NOT (INCLUDING SEARCH)
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EAST (PG-PUBS; US-PAT; JPO; EPO; DERWENT; IBM_TDB). SEE ATTACHED SEARCH PAPERS.	11/24/2005	NVT